

# BLF4G20-110B; BLF4G20S-110B

UHF power LDMOS transistor

Rev. 01 — 23 January 2006

Product data sheet

## 1. Product profile

### 1.1 General description

110 W LDMOS power transistor for base station applications at frequencies from 1800 MHz to 2000 MHz.

**Table 1: Typical performance**

$f = 1930 \text{ MHz to } 1990 \text{ MHz}$ ;  $T_{\text{case}} = 25^\circ \text{C}$ ; in a class-AB production test circuit.

| Mode of operation | $V_{\text{DS}}$<br>(V) | $P_{\text{L}}$<br>(W) | $G_{\text{p}}$<br>(dB)<br>(typ) | $\eta_{\text{D}}$<br>(%)<br>(typ) | $\text{ACPR}_{400}$<br>(dBc)<br>(typ) | $\text{ACPR}_{600}$<br>(dBc)<br>(typ) | $\text{EVM}_{\text{rms}}$<br>(%)<br>(typ) |
|-------------------|------------------------|-----------------------|---------------------------------|-----------------------------------|---------------------------------------|---------------------------------------|---|
| CW                | 28                     | 100                   | 13.4                            | 49                                | -                                     | -                                     | -   |
| GSM EDGE          | 28                     | 48 (AV)               | 13.8                            | 38.5                              | -61 [1]                               | -74 [2]                               | 2.1                                       |

[1]  $\text{ACPR}_{400}$  at 30 kHz resolution bandwidth.

[2]  $\text{ACPR}_{600}$  at 30 kHz resolution bandwidth.

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

### 1.2 Features

- Typical GSM EDGE performance at a frequency of 1930 MHz and 1990 MHz, a supply voltage of 28 V and an  $I_{\text{Dq}}$  of 650 mA:
  - ◆ Load power = 48 W (AV)
  - ◆ Gain = 13.8 dB (typ)
  - ◆ Efficiency = 38.5 % (typ)
  - ◆  $\text{ACPR}_{400} = -61$  dBc (typ)
  - ◆  $\text{ACPR}_{600} = -74$  dBc (typ)
  - ◆  $\text{EVM}_{\text{rms}} = 2.1$  % (typ)
- Easy power control
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (1800 MHz to 2000 MHz)

# PHILIPS

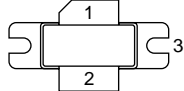
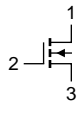
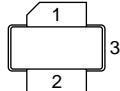
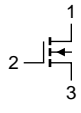
- Internally matched for ease of use

### 1.3 Applications

- RF power amplifiers for GSM, GSM EDGE and CDMA base stations and multicarrier applications in the 1800 MHz to 2000 MHz frequency range.

## 2. Pinning information

Table 2: Pinning

| Pin                            | Description                | Simplified outline  | Symbol  |
|--------------------------------|----------------------------|---|---|
| <b>BLF4G20-110B (SOT502A)</b>  |                            |   |   |
| 1                              | drain                      |   | <br><i>sym039</i>  |
| 2                              | gate                       |   |   |
| 3                              | source <a href="#">[1]</a> |   |   |
| <b>BLF4G20S-110B (SOT502B)</b> |                            |   |   |
| 1                              | drain                      |  | <br><i>sym039</i> |
| 2                              | gate                       |   |   |
| 3                              | source <a href="#">[1]</a> |   |   |

[1] Connected to flange

## 3. Ordering information

Table 3: Ordering information

| Type number   | Package |   |         |
|---------------|---------|---|---------|
|               | Name    | Description   | Version |
| BLF4G20-110B  | -       | flanged LDMOST ceramic package; 2 mounting holes; 2 leads | SOT502A |
| BLF4G20S-110B | -       | earless flanged LDMOST ceramic package; 2 leads           | SOT502B |

## 4. Limiting values

**Table 4: Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol    | Parameter            | Min  | Max  | Unit |
|-----------|----------------------|------|------|------|
| $V_{DS}$  | drain-source voltage | -    | 65   | V    |
| $V_{GS}$  | gate-source voltage  | -0.5 | +15  | V    |
| $I_D$     | drain current        | -    | 12   | A    |
| $T_{stg}$ | storage temperature  | -65  | +150 | °C   |
| $T_j$     | junction temperature | -    | 200  | °C   |

## 5. Thermal characteristics

**Table 5: Thermal characteristics**

| Symbol           | Parameter                                | Conditions                | Min | Typ  | Max  | Unit |
|------------------|--|---------------------------|-----|------|------|------|
| $R_{th(j-case)}$ | thermal resistance from junction to case | $T_{case} = 80\text{ °C}$ |     |      |      |      |
|                  |  | $P_L = 40\text{ W}$       | -   | 0.76 | 0.85 | K/W  |
|                  |  | $P_L = 100\text{ W}$      | -   | 0.65 | 0.74 | K/W  |

## 6. Characteristics

**Table 6: Characteristics**

$T_j = 25\text{ °C}$  unless otherwise specified.

| Symbol        | Parameter                        | Conditions  | Min | Typ | Max | Unit |
|---------------|----------------------------------|---|-----|-----|-----|------|
| $V_{(BR)DSS}$ | drain-source breakdown voltage   | $V_{GS} = 0\text{ V}; I_D = 0.9\text{ mA}$                    | 65  | -   | -   | V    |
| $V_{GS(th)}$  | gate-source threshold voltage    | $V_{DS} = 10\text{ V}; I_D = 180\text{ mA}$                   | 2.5 | 3.1 | 3.5 | V    |
| $V_{GSq}$     | gate-source quiescent voltage    | $V_{DS} = 28\text{ V}; I_D = 900\text{ mA}$                   | 2.7 | 3.2 | 3.7 | V    |
| $I_{DSS}$     | drain leakage current            | $V_{GS} = 0\text{ V}; V_{DS} = 28\text{ V}$                   | -   | -   | 3   | μA   |
| $I_{DSX}$     | drain cut-off current            | $V_{GS} = V_{GS(th)} + 6\text{ V}; V_{DS} = 10\text{ V}$      | 27  | 30  | -   | A    |
| $I_{GSS}$     | gate leakage current             | $V_{GS} = 15\text{ V}; V_{DS} = 0\text{ V}$                   | -   | -   | 300 | nA   |
| $g_{fs}$      | transfer conductance             | $V_{DS} = 10\text{ V}; I_D = 10\text{ A}$                     | -   | 9.0 | -   | S    |
| $R_{DS(on)}$  | drain-source on-state resistance | $V_{GS} = V_{GS(th)} + 6\text{ V}; I_D = 6\text{ A}$          | -   | 90  | -   | mΩ   |
| $C_{rs}$      | feedback capacitance             | $V_{GS} = 0\text{ V}; V_{DS} = 28\text{ V}; f = 1\text{ MHz}$ | -   | 2.5 | -   | pF   |

## 7. Application information

**Table 7: Application information**

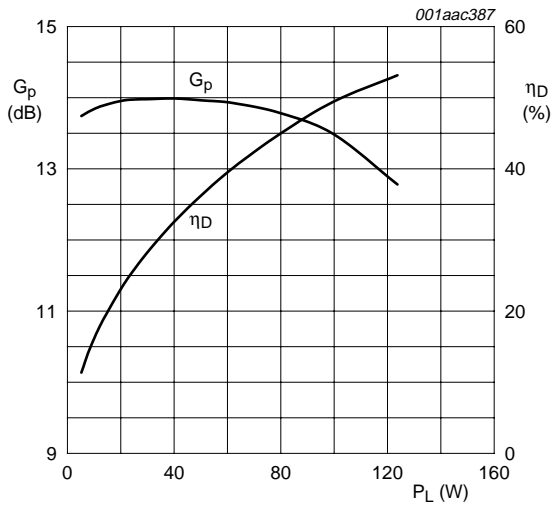
*Mode of operation: Two-tone (200 kHz tone spacing);  $f = 1930$  MHz and  $1990$  MHz.*

*$V_{DS} = 28$  V;  $I_{Dq} = 700$  mA;  $T_{case} = 25$  °C; unless otherwise specified; in a class-AB production test circuit.*

| Symbol   | Parameter                                | Conditions          | Min | Typ   | Max   | Unit |
|----------|--|---------------------|-----|-------|-------|------|
| $G_p$    | power gain                               | $P_{L(AV)} = 100$ W | 12  | 13.5  | -     | dB   |
| IRL      | input return loss                        | $P_{L(AV)} = 100$ W | -   | -10   | -6.5  | dB   |
| $\eta_D$ | drain efficiency                         | $P_{L(AV)} = 100$ W | 36  | 38.5  | -     | %    |
| IMD3     | third order intermodulation distortion   | $P_{L(AV)} = 100$ W | -   | -29   | -26   | dBc  |
| IMD5     | fifth order intermodulation distortion   | $P_{L(AV)} = 100$ W | -   | -39.5 | -36.5 | dBc  |
| IMD7     | seventh order intermodulation distortion | $P_{L(AV)} = 100$ W | -   | -53.5 | -50.5 | dBc  |

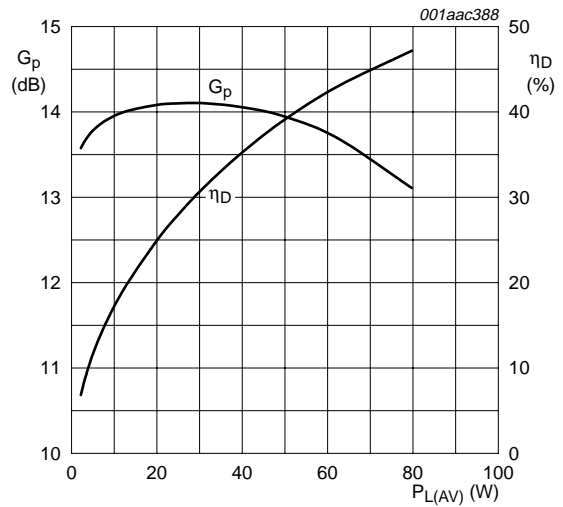
### 7.1 Ruggedness in class-AB operation

The BLF4G20(S)-110B is capable of withstanding a load mismatch corresponding to  $V_{SWR} = 10 : 1$  through all phases under the following conditions:  $V_{DS} = 28$  V;  $I_{Dq} = 650$  mA;  $P_L = 110$  W (CW);  $f = 1990$  MHz.



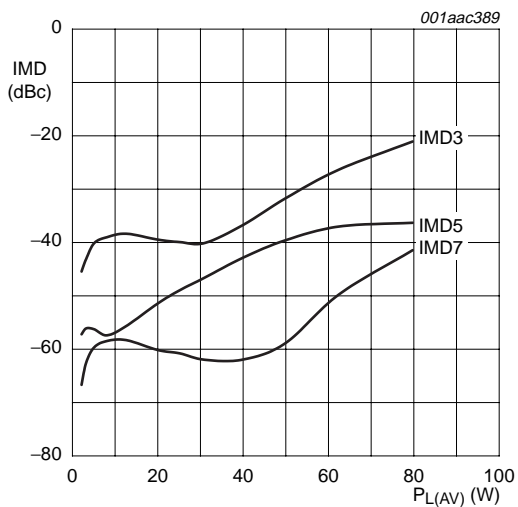
$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 650\text{ mA}$ ;  $T_{case} = 25\text{ }^{\circ}\text{C}$ ;  
 $f = 1990\text{ MHz}$

**Fig 1. One-tone CW power gain and drain efficiency as functions of load power; typical values**



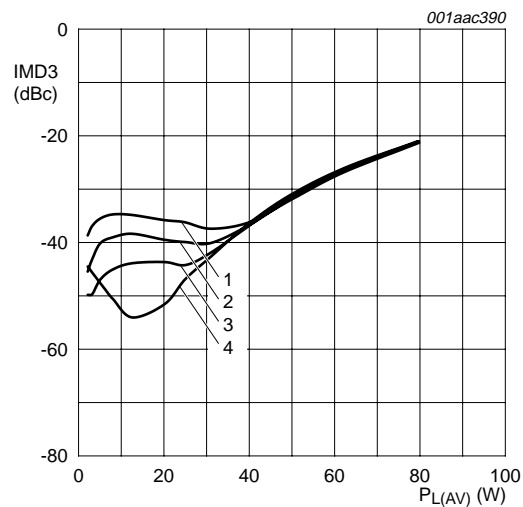
$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 650\text{ mA}$ ;  $T_{case} = 25\text{ }^{\circ}\text{C}$ ;  
 $f = 1990\text{ MHz}$

**Fig 2. Two-tone CW power gain and drain efficiency as functions of average load power; typical values**



$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 650\text{ mA}$ ;  $T_{case} = 25\text{ }^{\circ}\text{C}$ ;  
 $f = 1990\text{ MHz}$

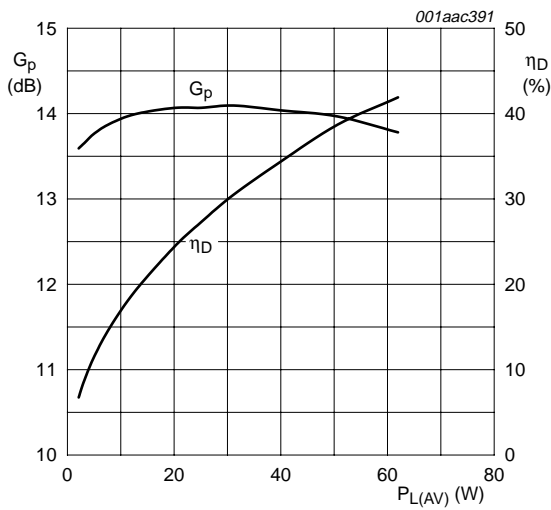
**Fig 3. Intermodulation distortion as a function of average load power; typical values**



$V_{DS} = 28\text{ V}$ ;  $T_{case} = 25\text{ }^{\circ}\text{C}$ ;  $f = 1990\text{ MHz}$

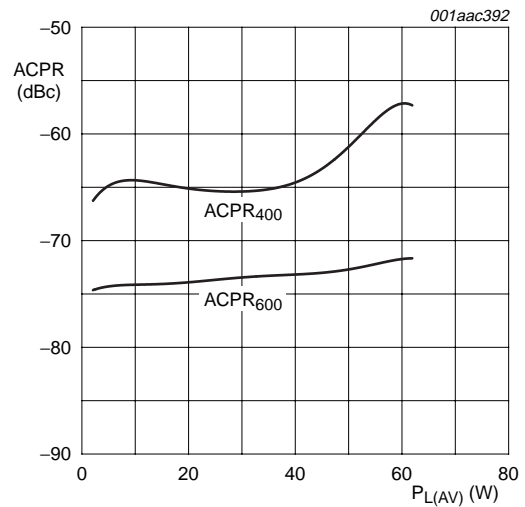
- (1)  $I_{Dq} = 550\text{ mA}$
- (2)  $I_{Dq} = 650\text{ mA}$
- (3)  $I_{Dq} = 750\text{ mA}$
- (4)  $I_{Dq} = 850\text{ mA}$

**Fig 4. Third order intermodulation distortion as a function of average load power; typical values**



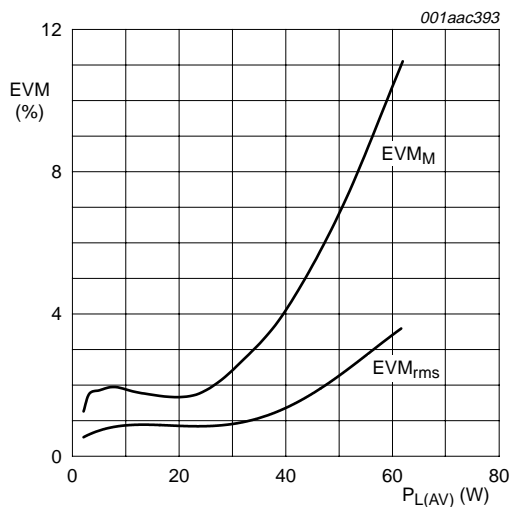
$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 650\text{ mA}$ ;  $T_{case} = 25\text{ }^\circ\text{C}$ ;  
 $f = 1990\text{ MHz}$

**Fig 5. GSM EDGE power gain and drain efficiency as functions of average load power; typical values**



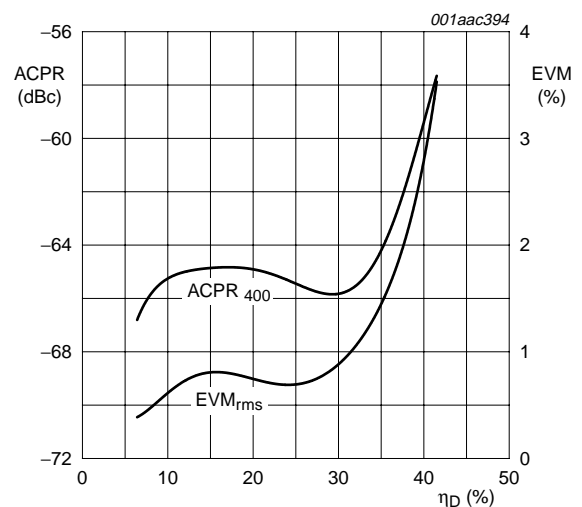
$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 650\text{ mA}$ ;  $T_{case} = 25\text{ }^\circ\text{C}$ ;  
 $f = 1990\text{ MHz}$

**Fig 6. GSM EDGE ACPR at 400 kHz and at 600 kHz as functions of average load power; typical values**



$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 650\text{ mA}$ ;  $T_{case} = 25\text{ }^\circ\text{C}$ ;  
 $f = 1990\text{ MHz}$

**Fig 7. GSM EDGE rms EVM and peak EVM as functions of average load power; typical values**



$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 650\text{ mA}$ ;  $T_{case} = 25\text{ }^\circ\text{C}$ ;  
 $f = 1990\text{ MHz}$

**Fig 8. GSM EDGE ACPR at 400 kHz and rms EVM as functions of drain efficiency; typical values**

**8. Test information**

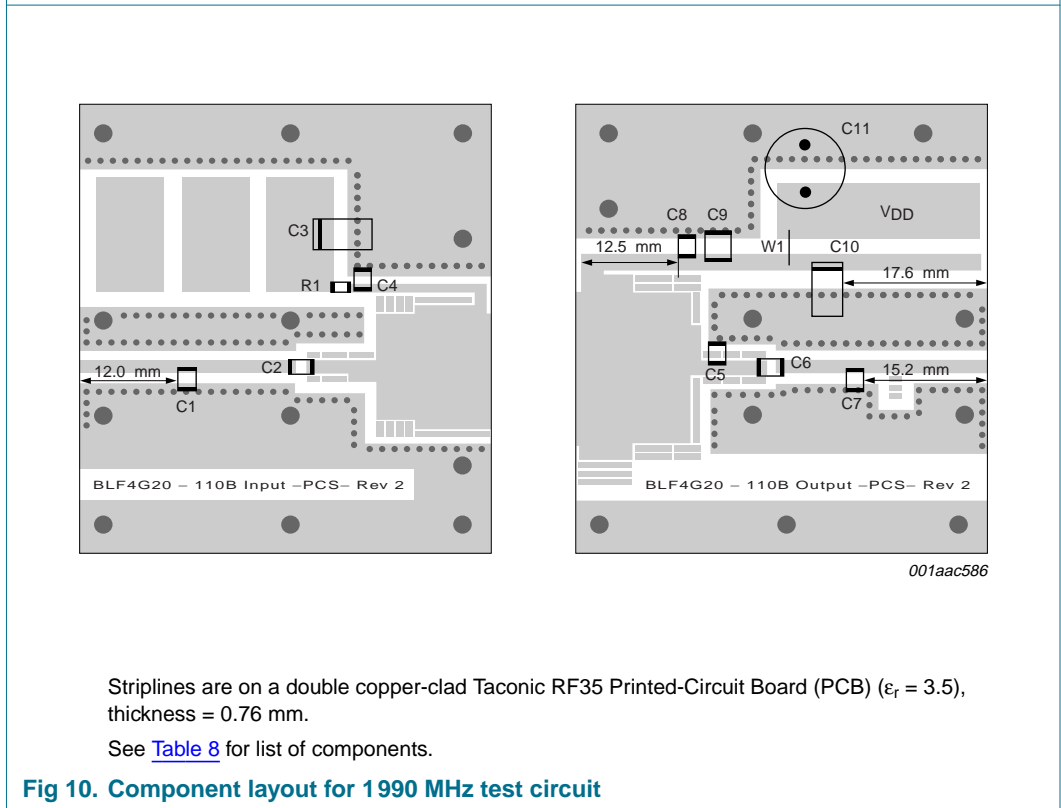
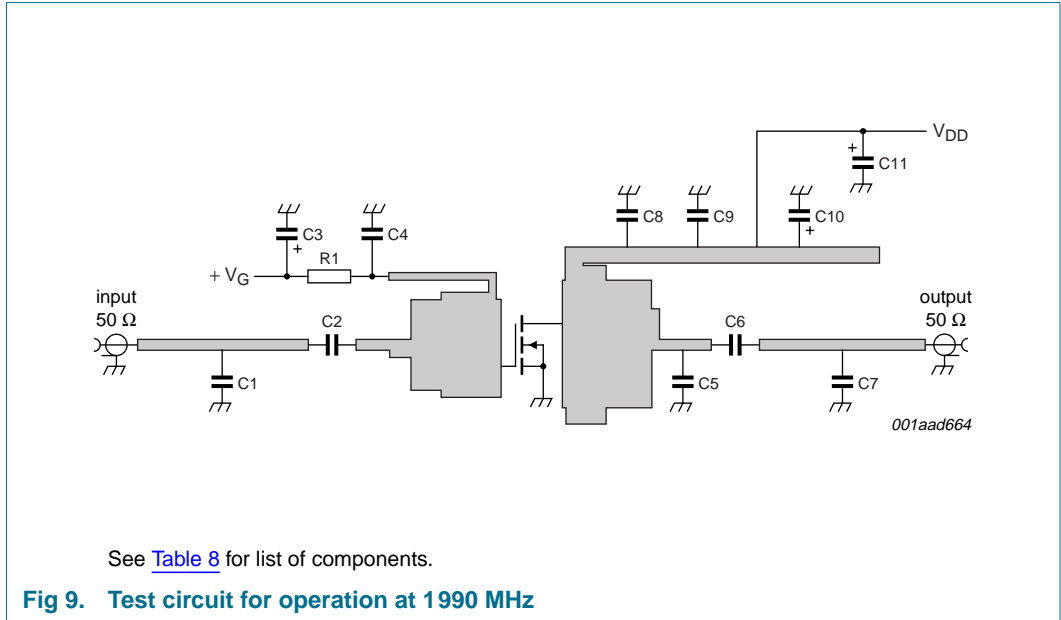


Table 8: List of components (see [Figure 9](#) and [10](#)).

| Component  | Description                       | Value             | Dimensions | Catalogue number |
|------------|-----------------------------------|-------------------|------------|------------------|
| C1         | multilayer ceramic chip capacitor | [1] 0.1 pF        |            |                  |
| C2, C4, C8 | multilayer ceramic chip capacitor | [1] 11 pF         |            |                  |
| C3, C10    | multilayer ceramic chip capacitor | 10 $\mu$ F        |            |                  |
| C5         | multilayer ceramic chip capacitor | [1] 0.5 pF        |            |                  |
| C6         | multilayer ceramic chip capacitor | [1] 8.2 pF        |            |                  |
| C7         | multilayer ceramic chip capacitor | [1] 0.2 pF        |            |                  |
| C9         | multilayer ceramic chip capacitor | [1] 1 $\mu$ F     |            | 1812X7R105KL2AB  |
| C11        | Philips electrolytic capacitor    | 220 $\mu$ F; 35 V |            |                  |
| R1         | Philips chip resistor             | 5.6 $\Omega$      | 0603       |                  |
| W1         | hand made wire                    |                   | 5 mm       |                  |

[1] American Technical Ceramics type 100B or capacitor of same quality.

**9. Package outline**

Flanged LDMOST ceramic package; 2 mounting holes; 2 leads

SOT502A

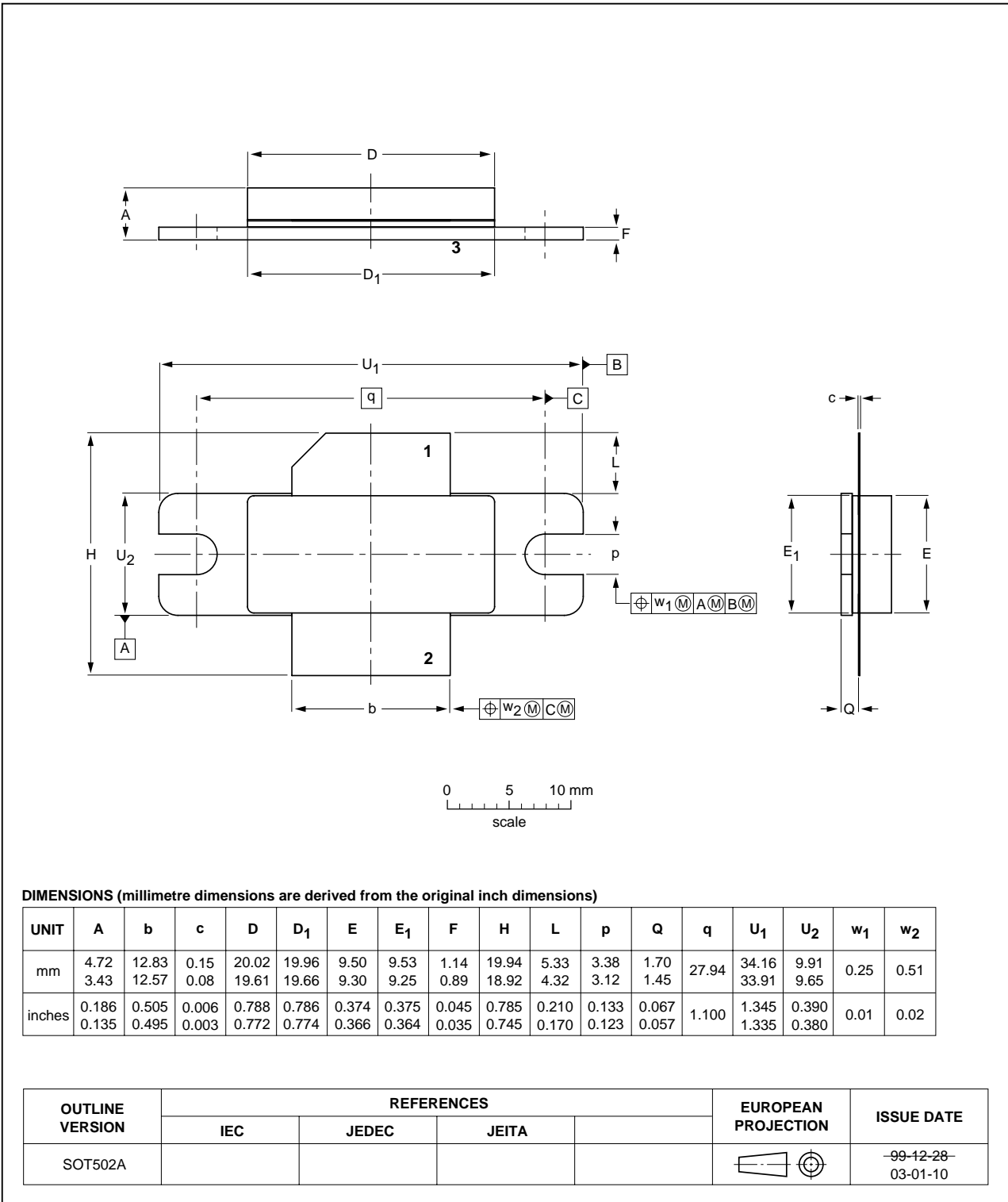


Fig 11. Package outline SOT502A

Earless flanged LDMOST ceramic package; 2 leads

SOT502B

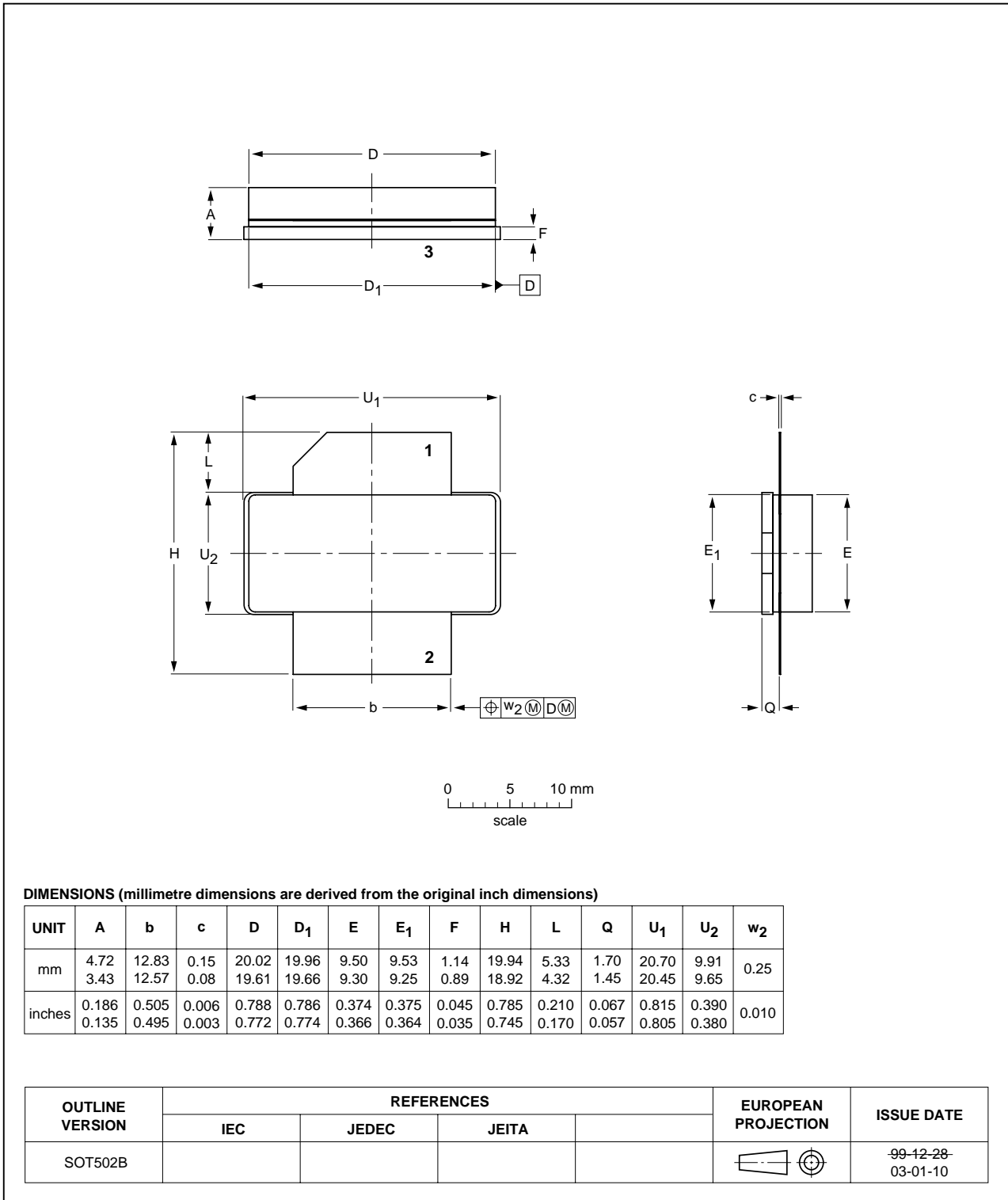


Fig 12. Package outline SOT502B

## 10. Abbreviations

**Table 9: List of abbreviations**

| <b>Abbreviation</b> | <b>Description</b>                           |
|---------------------|--|
| ACPR                | Adjacent Channel Power Ratio                 |
| CDMA                | Code Division Multiple Access                |
| CW                  | Continuous Wave                              |
| EDGE                | Enhanced Data rates for GSM Evolution        |
| EVM                 | Error Vector Magnitude                       |
| GSM                 | Global System for Mobile communications      |
| $I_{Dq}$            | quiescent drain current                      |
| LDMOS               | Laterally Diffused Metal Oxide Semiconductor |
| PEP                 | Peak Envelope Power                          |
| RF                  | Radio Frequency                              |
| VSWR                | Voltage Standing Wave Ratio                  |

## 11. Revision history

**Table 10: Revision history**

| Document ID               | Release date | Data sheet status  | Change notice | Doc. number    | Supersedes |
|---------------------------|--------------|--------------------|---------------|----------------|------------|
| BLF4G20-110B_4G20S-110B_1 | 20060123     | Product data sheet | -             | 6397 750 14611 | -          |

## 12. Data sheet status

| Level | Data sheet status <sup>[1]</sup> | Product status <sup>[2] [3]</sup> | Definition   |
|-------|----------------------------------|-----------------------------------|--|
| I     | Objective data                   | Development                       | This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.  |
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**Limiting values definition** — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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